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GTAH35025M2

Gallium Nitride 28V 25W, RF Power Transistor

Description

The GTAH35025M2 is a 25W GaN HEMT, designed for multiple applications, especially sub-6GHz MC-GSM/WCDMA/LTE/LTE-A up to 5000MHz.

There is no guarantee of performance when this part is used in applications designed Outside of these frequencies.

•Typical performance (on 1.6GHz narrow band fixture with device soldered) V_{DD}=28V I_{DQ}=100mA, Pulse CW, Pulse width=12uS, Duty cycle=10%.

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Freq(MHz)	P3(dBm)	P3(W)	Eff(%)
1610	45	31.62	74.66
1640	44.97	31.37	75.09
1675	45	31.62	74.63

Other application data available upon request: 1.8-2.2GHz,2.3-2.7, 4.4-5GHz

Applications and Features

- Suitable for wireless communication infrastructure, wideband amplifier, EMC testing, ISM etc.
- High Efficiency and Linear Gain Operations
- Thermally Enhanced Industry Standard Package
- High Reliability Metallization Process
- · Excellent thermal Stability and Excellent Ruggedness
- Compliant to Restriction of Hazardous Substances (RoHS) Directive 2002/95/EC

Important Note: Proper Biasing Sequence for GaN HEMT Transistors

Turning the device ON

- 1. Set VGS to the pinch--off (VP) voltage, typically -5 V
- 2. Turn on VDS to nominal supply voltage (28V)
- 3. Increase VGS until IDS current is attained
- 4. Apply RF input power to desired level

Turning the device OFF

- 1. Turn RF power off
- 2. Reduce VGS down to VP, typically -5 V
- 3. Reduce VDS down to 0 V
- 4. Turn off VGS

Table 1. Maximum Ratings

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Rating	Symbol	Value	Unit
DrainSource Voltage	V _{DSS}	150	Vdc
GateSource Voltage	V _{GS}	-10,+2	Vdc
Operating Voltage	V _{DD}	32	Vdc
Maximum Forward Gate Current @ Tc = 25°C	Igmax	6	mA
Storage Temperature Range	Tstg	-65 to +150	°C
Case Operating Temperature	Tc	+150	°C
Operating Junction Temperature(See note 1)	T _J	+200	°C
Total Device Power Dissipation (Derated above 25°C, see note 2)	Pdiss	33	w

Note: 1. Continuous operation at maximum junction temperature will affect MTTF

Table 2. Thermal Characteristics

Characteristic	Symbol	Value	Unit	
Thermal Resistance, Junction to Case	Rejc	5.3	C/W	
T _C = 85°C, T _J =200°C, RF CW operation, FEA mode	Keac	5.3	C/ VV	

Table 3. Electrical Characteristics (T_C = 25 ^oC unless otherwise noted)

^{2.} Bias Conditions should also satisfy the following expression: Pdiss < (Tj - Tc) / RJC and Tc = Tcase



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DC Characteristics

Characteristic	Conditions	Symbol	Min	Тур	Max	Unit
Drain-Source Breakdown Voltage	V _{GS} =-8V; I _{DS} =6mA	V _{DSS}	150			V
Gate Threshold Voltage	V _{DS} = 28V, I _D = 6mA	V _{GS} (th)		-2.7		V
Gate Quiescent Voltage	V _{DS} =28V, I _{DS} =100mA, Measured in Functional Test	V _{GS(Q)}		-2.27		V

Functional Tests (In 0.7-1GHz Production fixture, 50 ohm system): V_{DD} = 28 Vdc, I_{DQ} = 100 mA, f = 1.6GHz, WCDMA, Pout=5W

Characteristic	Symbol	Min	Тур	Max	Unit
Power Gain @	Gp		19	20	dB
Drain Efficiency @ P _{out}	Eff		39		%
Saturated Power by CCDF test	P _{SAT}		25	30	W
Input Return Loss	IRL		-7		dB
Mismatch stress at all phases (Device no damage)	VSWR		10:1		Ψ

TYPICAL CHARACTERISTICS

Figure 1. Power gain and drain efficiency as function of average load power Vdd=28V,ldq=100mA, Pulsed condition: 12us, 10%

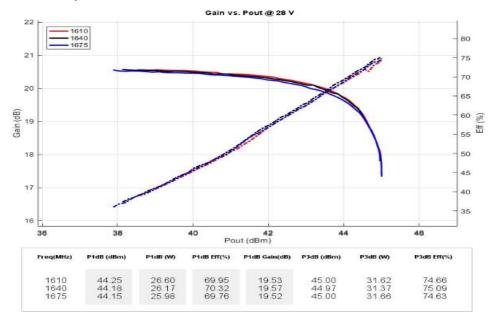




Figure 2. Network analyzer plots (S11/S21) Vdd=28V,ldq=100mA

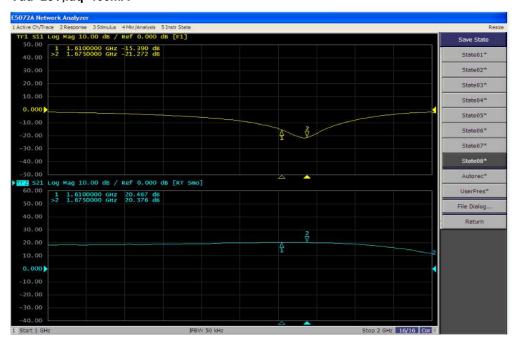
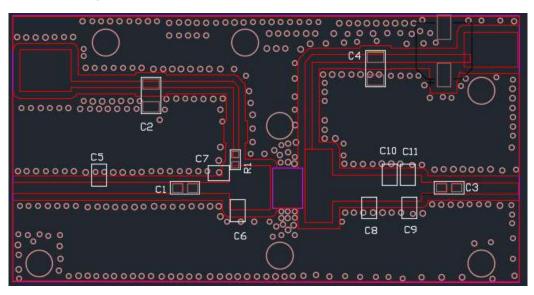


Figure 3. test fixture ,BOM and layout (Layout file upon request,)

PCB: 30 Mil Rogers 4350B

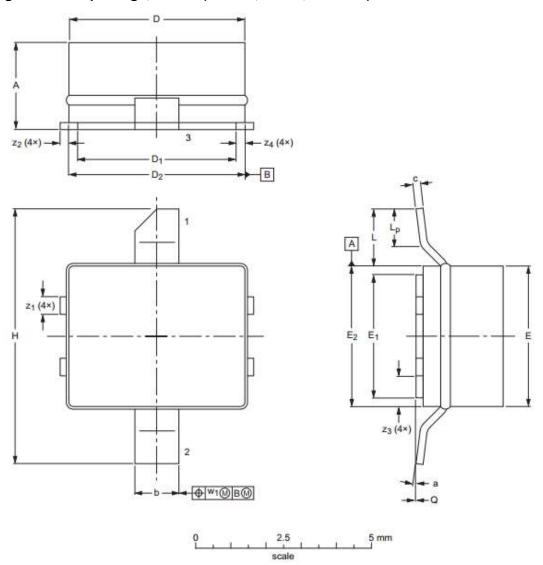


Designator	Value	Quantity	Package	Reference
C1 C2 C3 C4	33 pF	4	0805	ATC600F
C5 C7	1.2pF	2	0805	ATC600F
C6	4.7pF	1	0805	ATC600F
C8 C10 C11	0.3pF	3	0805	ATC600F
C9	0.1pF	1	0805	ATC600F
R1	10ohm	2	0603	



Package Outline

Earless Flanged ceramic package; 2 leads(1-Drain,2-Gate,3-Source)



UNIT	Α	b	С	D	D_1	Е	E ₁	E ₂	н	L	L₽	Q	W ₁	Z 1	Z 2	Z 3	Z 4	α
	2.34	1.35	0.23	5.16	4.65	4.14	3.63	4.14	7.49	2.03	1.02	0.1	0.05	0.58	0.25	0.97	0.51	7°
mm	2.13	1.19	0.18	5.00	4.50	3.99	3.48	3.99	7.24	1.27	0.51	0.0	0.25	0.43	0.18	0.81	0.00	0°

OUTLINE		REFERENCE	EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	JEITA	PROJECTION	1330E BATE
PKG-MM					18/6/2014

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Revision history

Table 4. Document revision history

Date	Revision	Datasheet Status
2018/8/2	V1.0	Preliminary datasheet creation
2021/11/3	V1.1	1.8-2.2, 2.3-2.7GHz data ready
2021/12/21	V1.2	4.4-5GHz data ready

Application data based on ZXY-21-10

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